

## FEATURES

**Conversion gain: 13 dB typical**  
**Image rejection: 30 dBc typical**  
**Noise figure: 5 dB typical**  
**Input IP3: 1 dBm typical**  
**Input IP2: 28 dBm typical**  
**Input P1dB: -8 dBm typical**  
**6× LO leakage at RFIN: <-55 dBm typical**  
**I/Q amplitude imbalance: 0.2 dB typical**  
**I/Q phase imbalance: 5° typical**  
**Fully integrated, surface-mount, 34-terminal, 11 mm × 13 mm LGA\_CAV package**

## APPLICATIONS

**E-band communication systems**  
**High capacity wireless backhauls**  
**Test and measurement**  
**Aerospace and defense**

## FUNCTIONAL BLOCK DIAGRAM

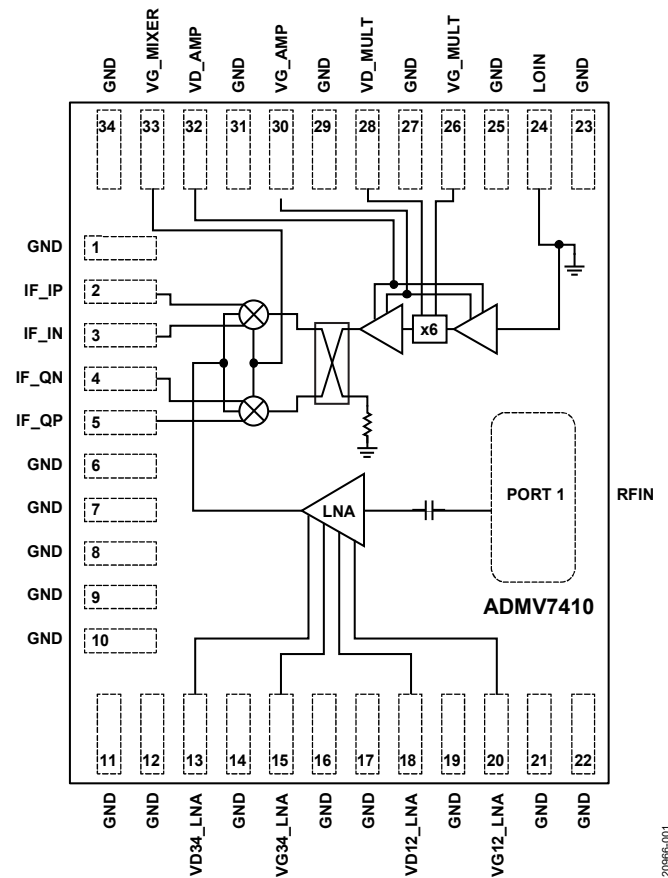


Figure 1.

## GENERAL DESCRIPTION

The ADMV7410 is a fully integrated system in package (SiP) in phase/quadrature (I/Q) downconverter that operates between an intermediate frequency (IF) output range of dc and 2 GHz and a RF input range of 71 GHz and 76 GHz. The device provides a small signal conversion gain of 13 dB with 30 dBc of image rejection. The ADMV7410 uses a low noise amplifier followed by an image rejection mixer that is driven by a 6× local oscillator (LO) multiplier. Differential I and Q mixer

outputs are provided for direct conversion applications. Alternatively, the outputs can be combined using an external 90° hybrid and two external 180° hybrids for single-ended applications.

The ADMV7410 comes in a fully integrated, surface-mount, 34-terminal, 11 mm × 13 mm, chip array small outline no lead cavity (LGA\_CAV) package. The ADMV7410 operates over the -40°C to +85°C case temperature range.

Rev. B

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**REVISION HISTORY**

**10/2021—Rev. A to Rev. B**

Updated Outline Dimensions.....	25
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**7/2019—Revision A: Initial Version**

## SPECIFICATIONS

$T_A = -40^{\circ}\text{C}$  to  $+85^{\circ}\text{C}$ , IF = 1 GHz, LO power = 4 dBm, VD\_AMP = +4 V, VG\_MIXER = -1 V, VD\_MULT = +1.5 V, VD12\_LNA = +2 V, and VD34\_LNA = +4 V, unless otherwise noted. Measurements performed as a downconverter with lower sideband selected and an external  $90^{\circ}$  hybrid followed by two external  $180^{\circ}$  hybrids at the IF ports, unless otherwise noted.

Table 1.

Parameter	Symbol	Min	Typ	Max	Unit
<b>OPERATING CONDITIONS</b>					
Frequency Range					
RF		71		76	GHz
LO		11.5		13	GHz
IF Output		DC		2	GHz
LO Drive Level Range		0	4	8	dBm
<b>PERFORMANCE</b>					
Conversion Gain		7	13	20	dB
Gain Flatness			2		dB
Image Rejection		15	30		dBc
Input Power for 1 dB Compression (Input P1dB)		-13	-8		dBm
Input Third-Order Intercept (Input IP3)		-6	1		dBm
Input Second-Order Intercept (Input IP2)		15	28		dBm
6× LO Leakage at the RF Input Port (RFIN)			<-55	-50	dBm
I/Q Amplitude Imbalance			0.2	3	dB
I/Q Phase Imbalance		-10	5	10	Degrees
Noise Figure			5	8	dB
Return Loss					
RFIN			10		dB
LO Input Port (LOIN)			10		dB
Baseband Output Port <sup>1</sup>			10		dB
<b>DIFFERENTIAL BASEBAND OUTPUT PORT IMPEDANCE</b>			100		$\Omega$
<b>LOIN PORT IMPEDANCE</b>			50		$\Omega$
<b>POWER SUPPLY</b>					
DC Power Dissipation			1	1.25	W
Low Noise Amplifier Gate Voltage	VG12_LNA, VG34_LNA	-2		0	V
Low Noise Amplifier Drain Voltage					
First and Second Stage	VD12_LNA	1.9	2	2.1	V
Third and Fourth Stage	VD34_LNA	3.8	4	4.2	V
Multiplier Drain Voltage	VD_MULT	1.42	1.5	1.58	V
Multiplier Gate Voltage	VG_MULT	-2		0	V
Mixer Gate Voltage	VG_MIX	-2		0	V
Low Noise Amplifier Supply Current	I <sub>VD12_LNA</sub> and I <sub>VD34_LNA</sub>		66		mA
Amplifier Drain Current	I <sub>VD_AMP</sub>		175		mA
Multiplier Drain Current	I <sub>VD_MULT</sub>		80		mA

<sup>1</sup> Measurements taken without external hybrids at the IF ports.

## ABSOLUTE MAXIMUM RATINGS

Table 2.

Parameter	Rating
VD_AMP	4.5 V
VD_MULT	3 V
VD12_LNA and VD34_LNA	4.5 V
VG_AMP	-3 V to +0.2 V
VG_MULT	-3 V to +0.2 V
VG12_LNA and VG34_LNA	-3 V to +0.2 V
LO Drive	10 dBm
Baseband Input (IF_IP, IF_IN, IF_QP, and IF_QN)	4 dBm
IF Source and Sink Current	3 mA
Nominal Junction Temperature (T <sub>A</sub> = 85°C)	137°C
Maximum Junction Temperature (to Maintain 3 Million Hours Mean Time to Failure (MTTF))	175°C
Operating Temperature Range	-40°C to +85°C
Storage Temperature Range	-55°C to +150°C
Maximum Peak Reflow Temperature for Moisture Sensitivity Level 3 (MSL3)	260°C
Thermal Humidity Bias (THB)	JESD22-A101 <sup>1,2,3</sup>
Thermal Humidity Storage (THS)	JESD22-A101 <sup>1,3</sup>
Electrostatic Discharge (ESD) Sensitivity	
Human Body Model (HBM)	250 V
Field Induced Charged Device Model (FICDM)	500 V

<sup>1</sup> Samples subject to preconditioning (per J-STD-020 Level 3) prior to the start of the stress test. Level 3 preconditioning consists of the following: bake for 24 hours at 125°C, unbiased soak for 192 hours at 30°C and 60% relative humidity (RH), and reflow of three passes through an oven with a peak temperature of 260°C.

<sup>2</sup> Results valid for 400 mW of nominal dc power dissipation for all active devices. Analog Devices, Inc., recommends that users perform their own THB test for all other bias conditions.

<sup>3</sup> Valid for package vent hole solder sealed or unsealed during test.

Stresses at or above those listed under Absolute Maximum Ratings may cause permanent damage to the product. This is a stress rating only; functional operation of the product at these or any other conditions above those indicated in the operational section of this specification is not implied. Operation beyond the maximum operating conditions for extended periods may affect product reliability.

## THERMAL RESISTANCE

Thermal performance is directly linked to printed circuit board (PCB) design and operating environment. Careful attention to PCB thermal design is required.

$\theta_{JC}$  is the junction to case (or die to package) thermal resistance.

Table 3. Thermal Resistance<sup>1</sup>

Package Type	$\theta_{JC}$	Unit
CE-34-2	52.4	°C/W

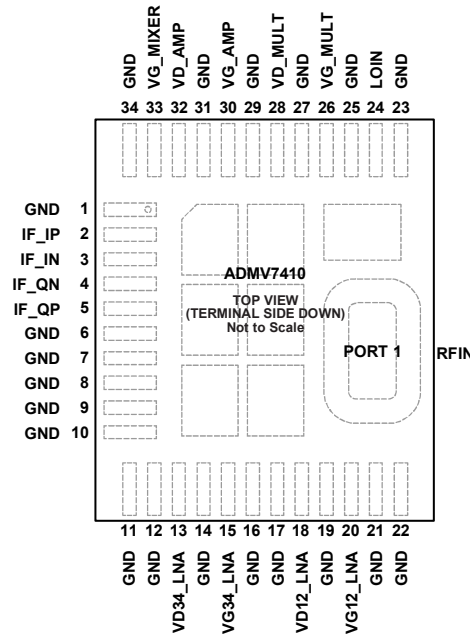
<sup>1</sup> Thermal impedance simulated values are based on a JEDEC 252P test board with 11 mm × 13 mm thermal vias. Refer to JEDEC standard JESD51-2 for additional information.

## ESD CAUTION



**ESD (electrostatic discharge) sensitive device.** Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

# PIN CONFIGURATION AND FUNCTION DESCRIPTIONS



NOTES  
 1. EXPOSED PADS. THE EXPOSED GROUND PADS MUST BE CONNECTED TO RF AND DC GROUND.

Figure 2. Pin Configuration

Table 4. Pin Function Descriptions

Pin No.	Mnemonic	Description
1, 6 to 12, 14, 16, 17, 19, 21 to 23, 25, 27, 29, 31, 34	GND	Ground Connections. These pins must be connected to RF and dc ground.
2	IF_IP	Positive IF In Phase Output. This pin is dc-coupled. When operation to dc is not required, block this pin externally using a series capacitor with a value chosen to pass the necessary frequency range. For operation to dc, this pin must not source or sink more than 3 mA of current or device malfunction and device failure may result.
3	IF_IN	Negative IF In Phase Output. This pin is dc-coupled. When operation to dc is not required, block this pin externally using a series capacitor with a value chosen to pass the necessary frequency range. For operation to dc, this pin must not source or sink more than 3 mA of current or device malfunction and device failure may result.
4	IF_QN	Negative IF Quadrature Output. This pin is dc-coupled. When operation to dc is not required, block this pin externally using a series capacitor with a value chosen to pass the necessary frequency range. For operation to dc, this pin must not source or sink more than 3 mA of current or device malfunction and device failure may result.
5	IF_QP	Positive IF Quadrature Output. This pin is dc-coupled. When operation to dc is not required, block this pin externally using a series capacitor with a value chosen to pass the necessary frequency range. For operation to dc, this pin must not source or sink more than 3 mA of current or device malfunction and device failure may result.
13	VD34_LNA	Drain Voltage for the Third and Fourth Stage Low Noise Amplifier. See Figure 75 for the recommended external components.
15	VG34_LNA	Gate Voltage for the Third and Fourth Stage Low Noise Amplifier. See Figure 75 for the recommended external components.
18	VD12_LNA	Drain Voltage for the First and Second Stage Low Noise Amplifier. See Figure 75 for the recommended external components.
20	VG12_LNA	Gate Voltage for the First and Second Stage Low Noise Amplifier. See Figure 75 for the recommended external components.

Pin No.	Mnemonic	Description
24	LOIN	LO Input. This pin is dc-coupled and matched to 50 Ω.
26	VG_MULT	Gate Voltage for the LO Multiplier. See Figure 75 for the recommended external components.
28	VD_MULT	Drain Voltage for the LO Multiplier. See Figure 75 for the recommended external components.
30	VG_AMP	Gate Voltage for the LO Amplifier. See Figure 75 for the recommended external components.
32	VD_AMP	Drain Voltage for the LO Amplifier. See Figure 75 for the recommended external components.
33	VG_MIXER	Gate Voltage for the Field Effect Transistor (FET) Mixer. See Figure 75 for the recommended external components.
PORT 1	RFIN	WR-12 Waveguide Port. This port is ac-coupled and matched to the waveguide input impedance.
	EPAD	Exposed Pads. The exposed ground pads must be connected to RF and dc ground.

INTERFACE SCHEMATICS



Figure 3. GND Interface Schematic

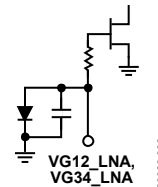


Figure 6. VG12\_LNA and VG34\_LNA Interface Schematic

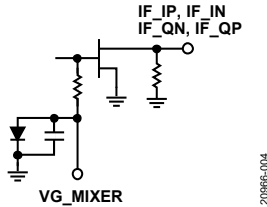


Figure 4. IF\_IP, IF\_IN, IF\_QN, IF\_QP, and VG\_MIXER Interface Schematic

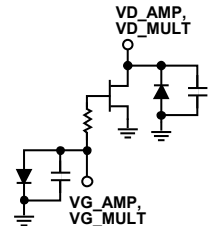


Figure 7. VG\_MULT, VD\_MULT, VG\_AMP, and VD\_AMP Interface Schematic

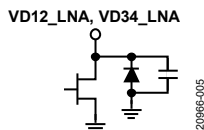


Figure 5. VD12\_LNA and VD34\_LNA Interface Schematic

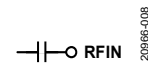


Figure 8. RFIN Interface Schematic

# TYPICAL PERFORMANCE CHARACTERISTICS

T<sub>A</sub> = 25°C, IF = 1 GHz, RFIN = -20 dBm combined, LO power = +4 dBm, and lower sideband selected, unless otherwise noted.

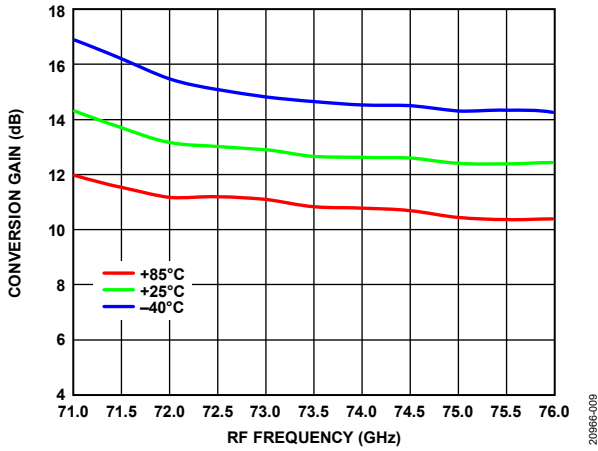


Figure 9. Conversion Gain vs. RF Frequency over Temperature

20986-009

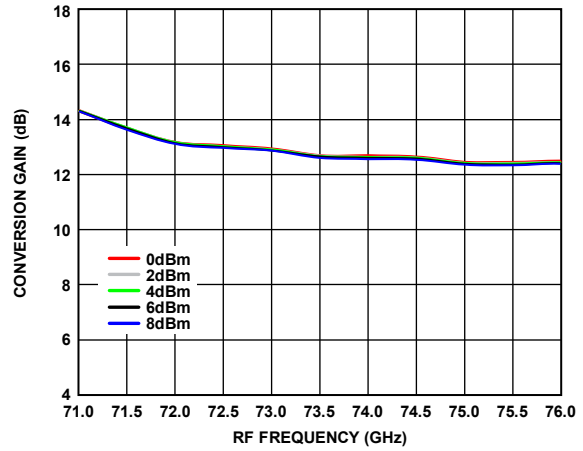


Figure 12. Conversion Gain vs. RF Frequency over LO Power

20986-012

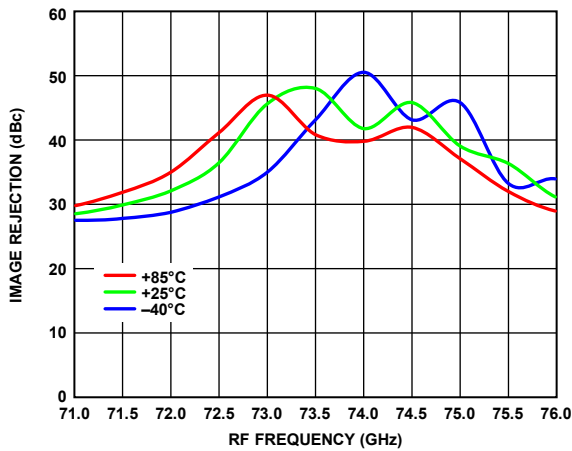


Figure 10. Image Rejection vs. RF Frequency over Temperature

20986-010

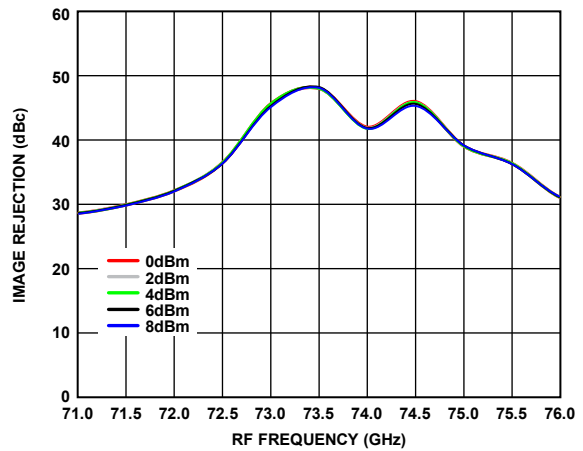


Figure 13. Image Rejection vs. RF Frequency over LO Power

20986-013

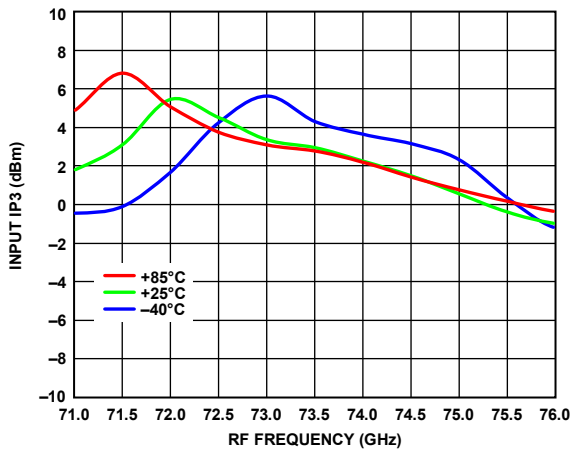


Figure 11. Input IP3 vs. RF Frequency over Temperature

20986-011

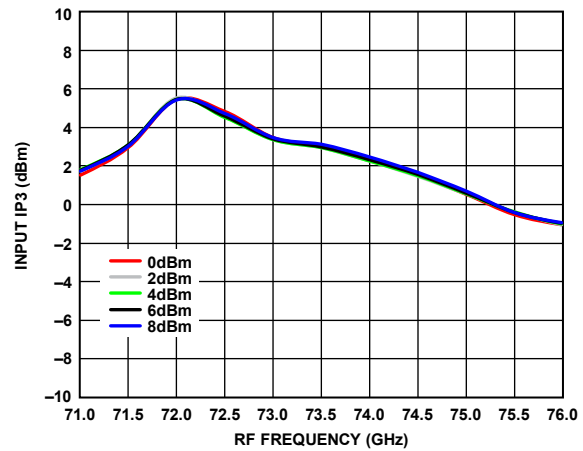


Figure 14. Input IP3 vs. RF Frequency over LO Power

20986-014

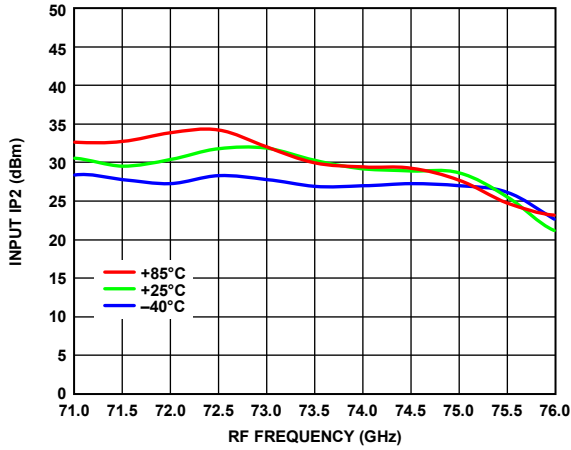


Figure 15. Input IP2 vs. RF Frequency over Temperature

20986-015

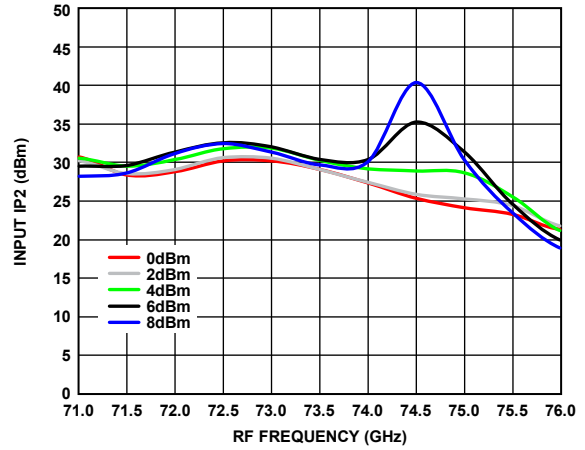


Figure 18. Input IP2 vs. RF Frequency over LO Power

20986-018

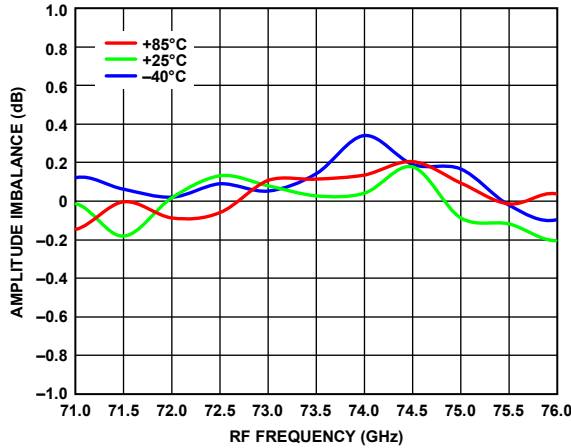


Figure 16. Amplitude Imbalance vs. RF Frequency over Temperature

20986-017

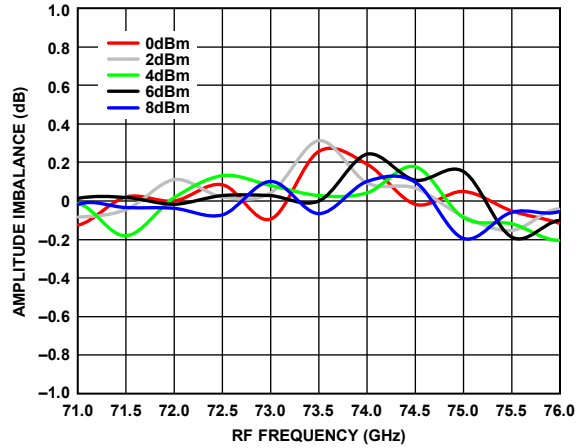


Figure 19. Amplitude Imbalance vs. RF Frequency over LO Power

20986-020

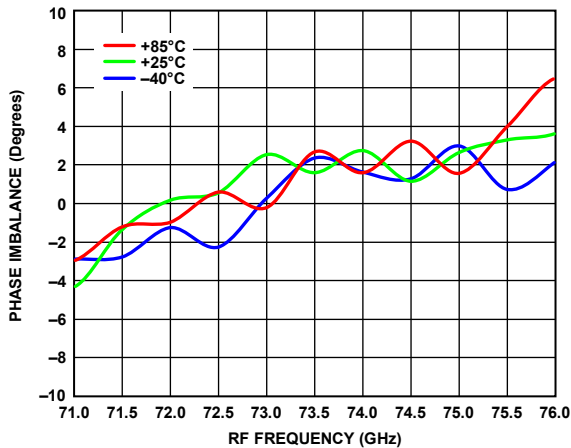


Figure 17. Phase Imbalance vs. RF Frequency over Temperature

20986-021

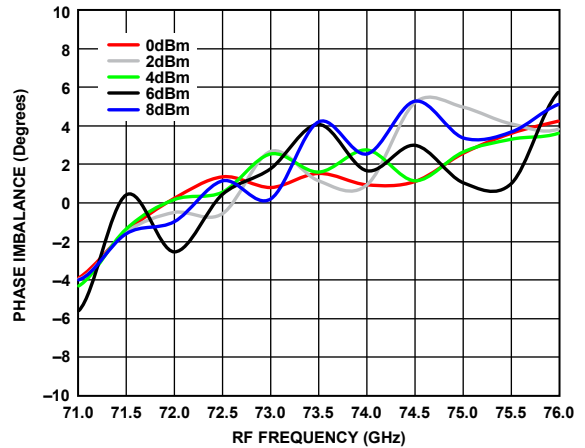


Figure 20. Phase Imbalance vs. RF Frequency over LO Power

20986-023



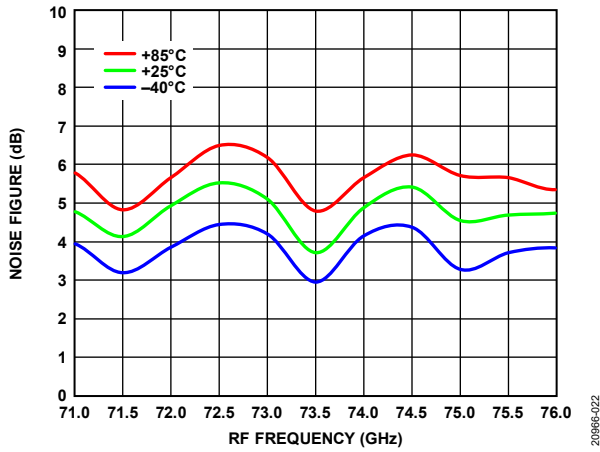


Figure 21. Noise Figure vs. RF Frequency over Temperature

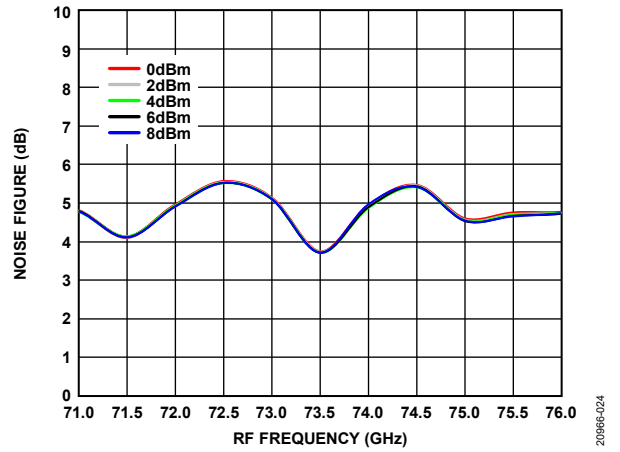


Figure 23. Noise Figure vs. RF Frequency over LO Power

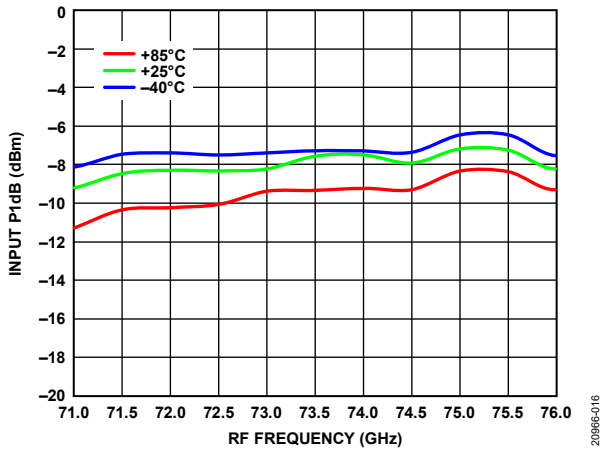


Figure 22. Input P1dB vs. RF Frequency over Temperature

20986-022

20986-024

20986-016

T<sub>A</sub> = 25°C, IF = 0.1 GHz, RFIN = -20 dBm combined, LO power = +4 dBm, and lower sideband selected, unless otherwise noted.

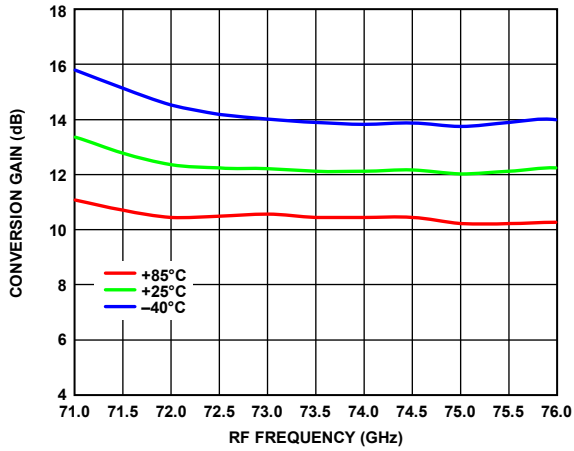


Figure 24. Conversion Gain vs. RF Frequency over Temperature

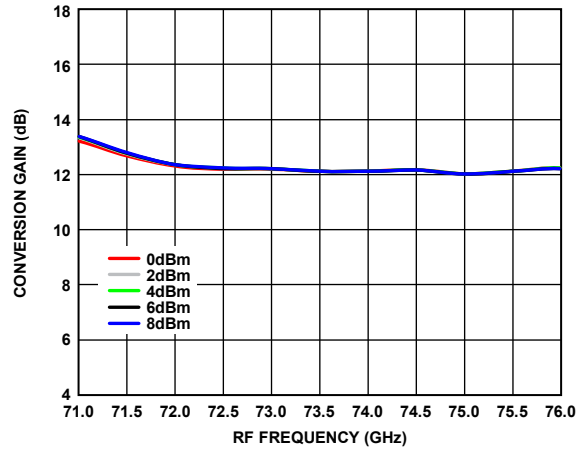


Figure 27. Conversion Gain vs. RF Frequency over LO Power

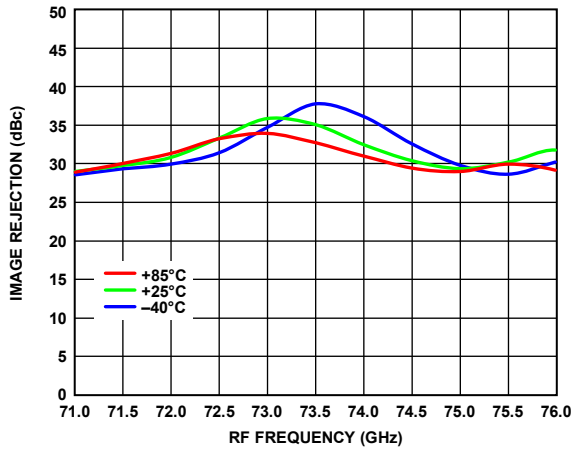


Figure 25. Image Rejection vs. RF Frequency over Temperature

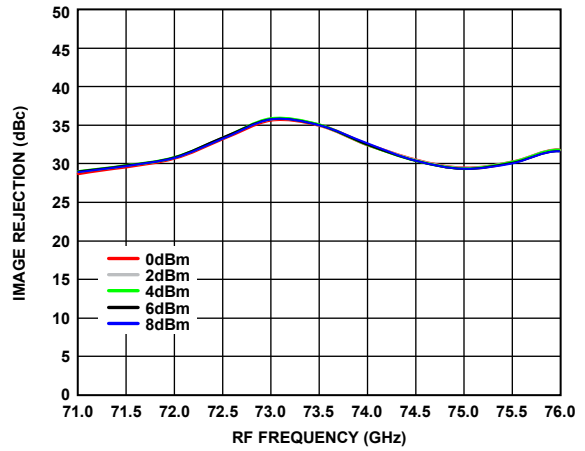


Figure 28. Image Rejection vs. RF Frequency over LO Power

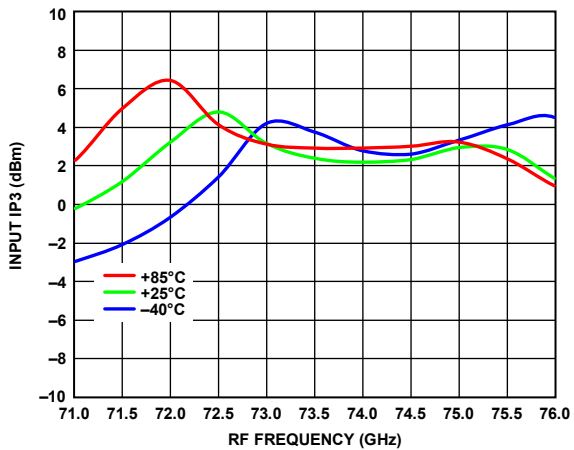


Figure 26. Input IP3 vs. RF Frequency over Temperature

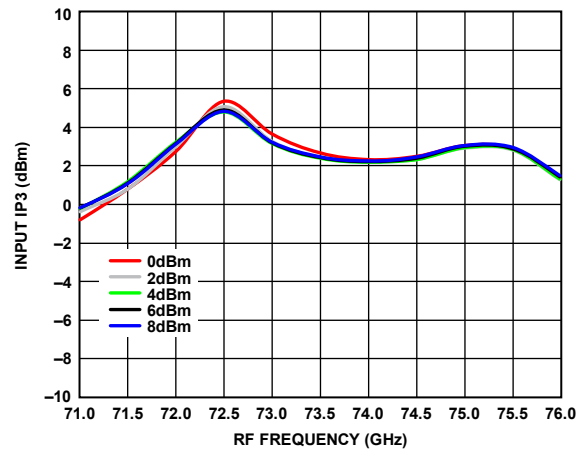


Figure 29. Input IP3 vs. RF Frequency over LO Power

20986-025

20986-028

20986-026

20986-029

20986-027

20986-030

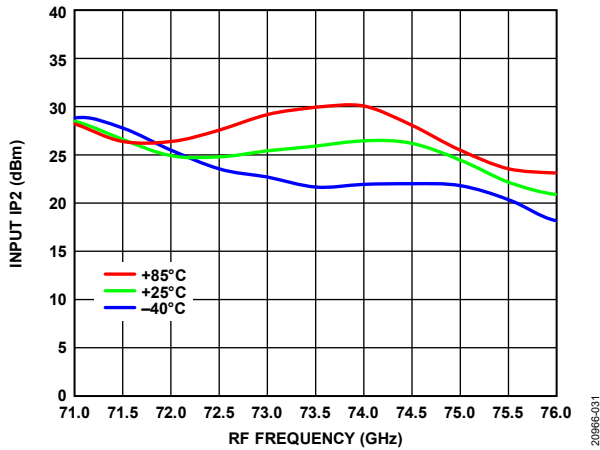


Figure 30. Input IP2 vs. RF Frequency over Temperature

20986-031

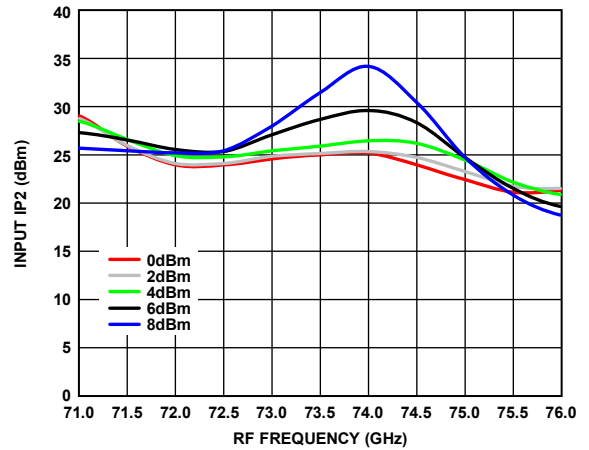


Figure 33. Input IP2 vs. RF Frequency over LO Power

20986-034

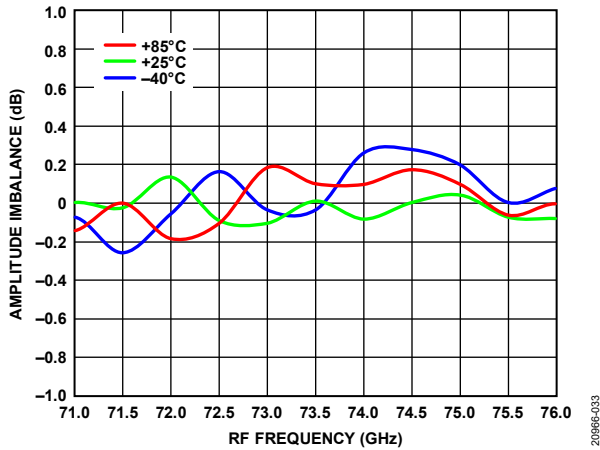


Figure 31. Amplitude Imbalance vs. RF Frequency over Temperature

20986-033

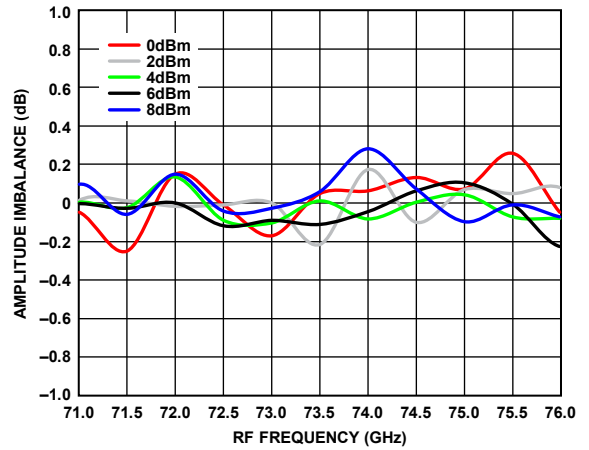


Figure 34. Amplitude Imbalance vs. RF Frequency over LO Power

20986-036

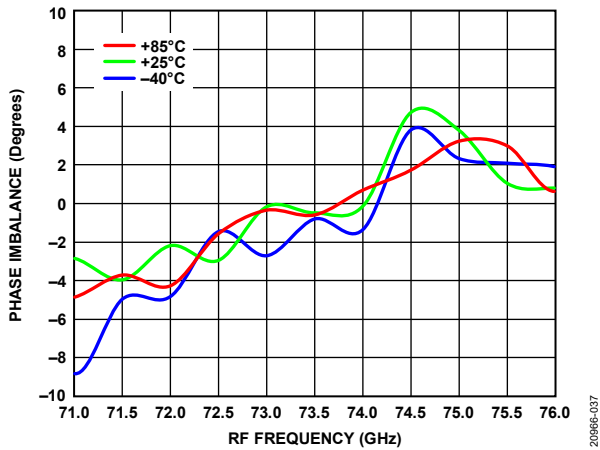


Figure 32. Phase Imbalance vs. RF Frequency over Temperature

20986-037

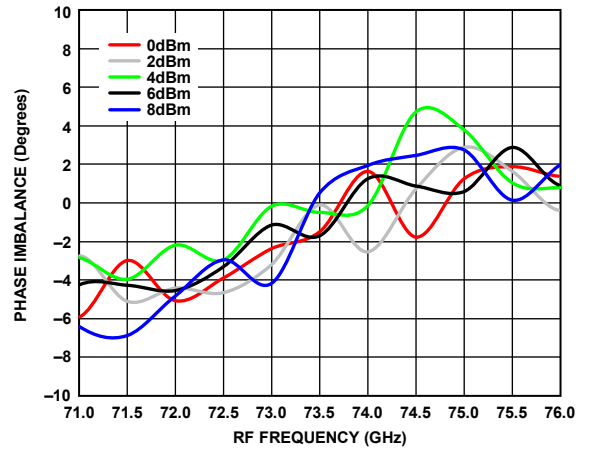


Figure 35. Phase Imbalance vs. RF Frequency over LO Power

20986-039

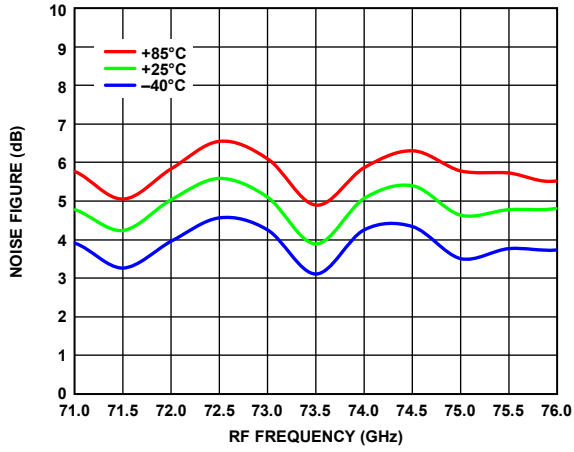


Figure 36. Noise Figure vs. RF Frequency over Temperature

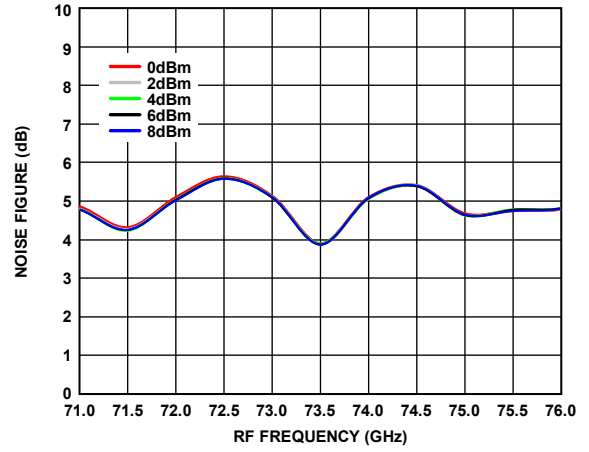


Figure 38. Noise Figure vs. RF Frequency over LO Power

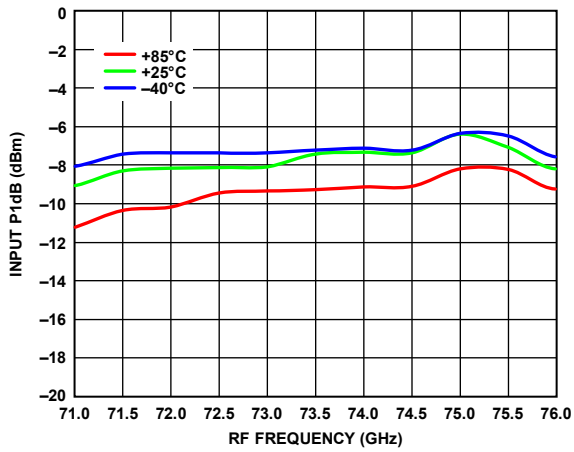


Figure 37. Input P1dB vs. RF Frequency over Temperature

20966-038

20966-040

20966-032

T<sub>A</sub> = 25°C, IF = 0.5 GHz, RFIN = -20 dBm combined, LO power = +4 dBm, and lower sideband selected, unless otherwise noted.

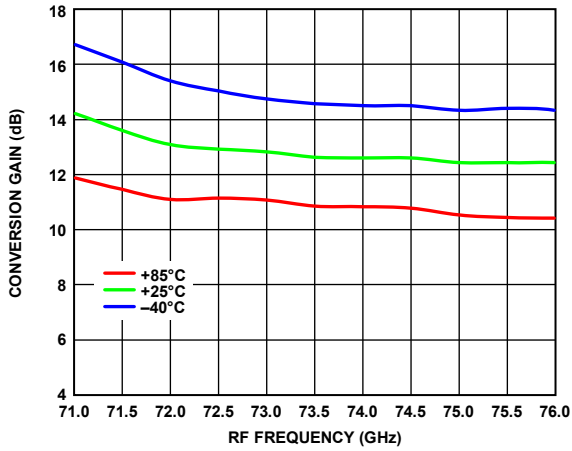


Figure 39. Conversion Gain vs. RF Frequency over Temperature

20866-041

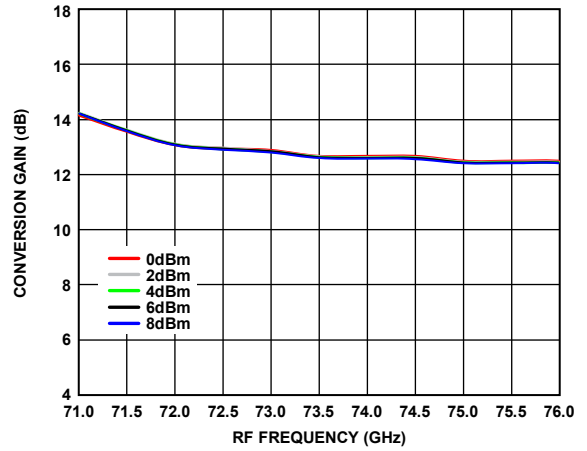


Figure 42. Conversion Gain vs. RF Frequency over LO Power

20866-044

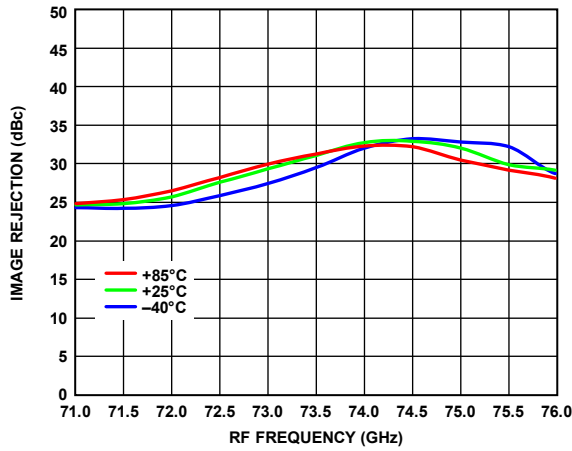


Figure 40. Image Rejection vs. RF Frequency over Temperature

20866-042

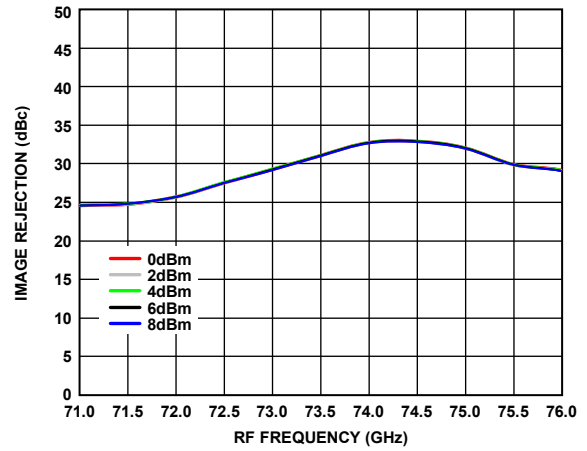


Figure 43. Image Rejection vs. RF Frequency over LO Power

20866-045

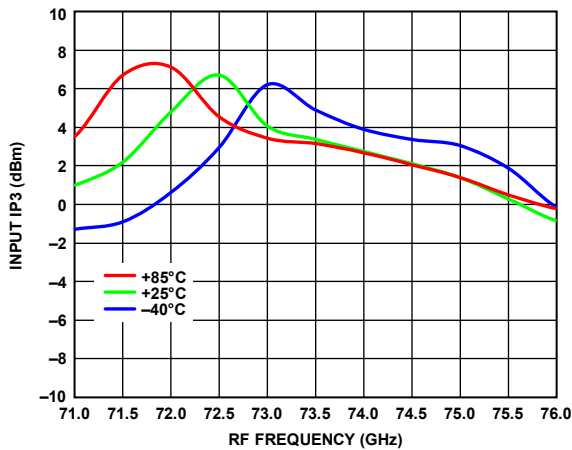


Figure 41. Input IP3 vs. RF Frequency over Temperature

20866-043

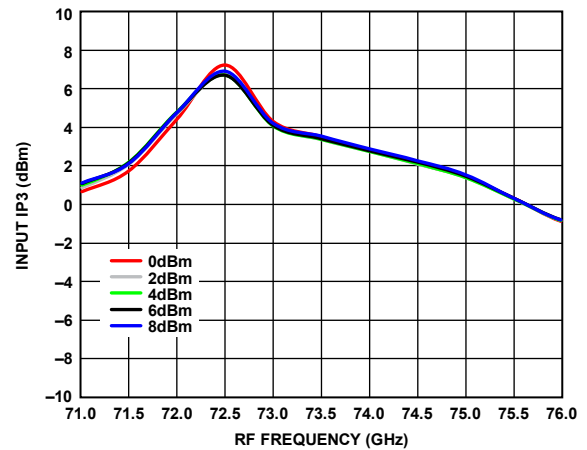


Figure 44. Input IP3 vs. RF Frequency over LO Power

20866-046

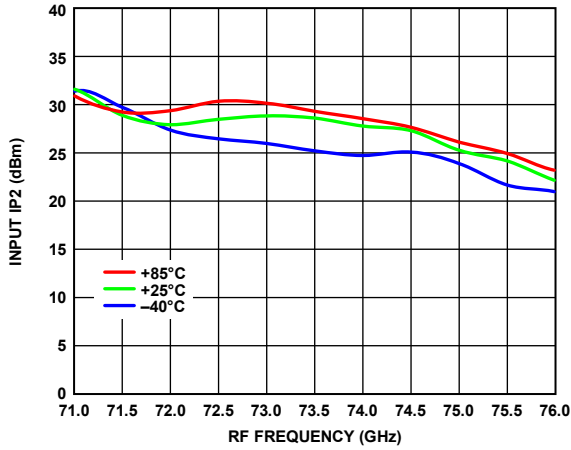


Figure 45. Input IP2 vs. RF Frequency over Temperature

20986-047

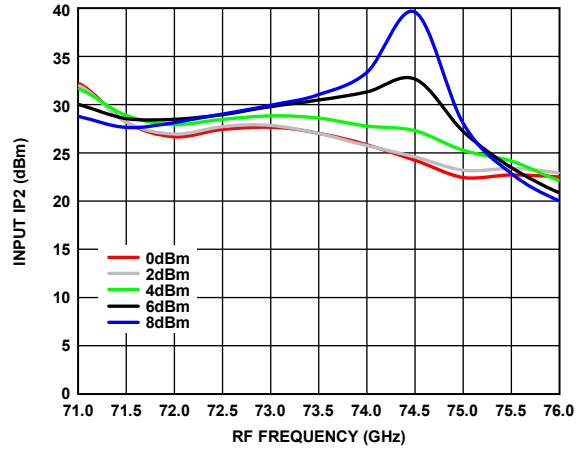


Figure 48. Input IP2 vs. RF Frequency over LO Power

20986-050

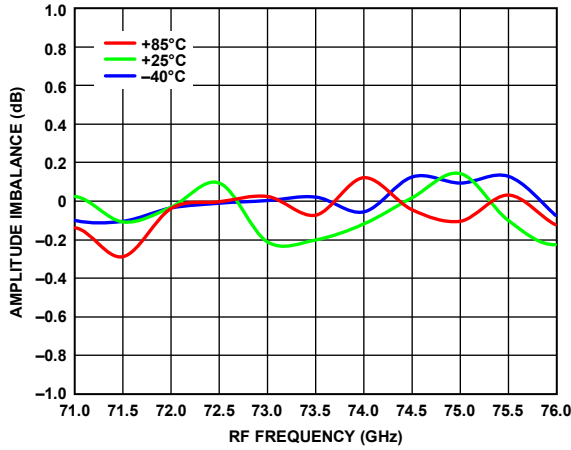


Figure 46. Amplitude Imbalance vs. RF Frequency over Temperature

20986-049

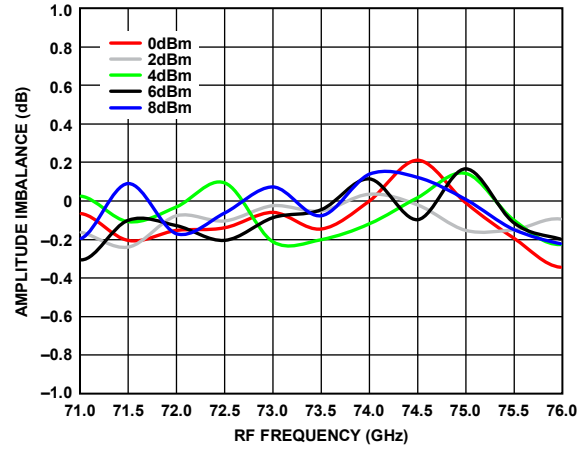


Figure 49. Amplitude Imbalance vs. RF Frequency over LO Power

20986-052

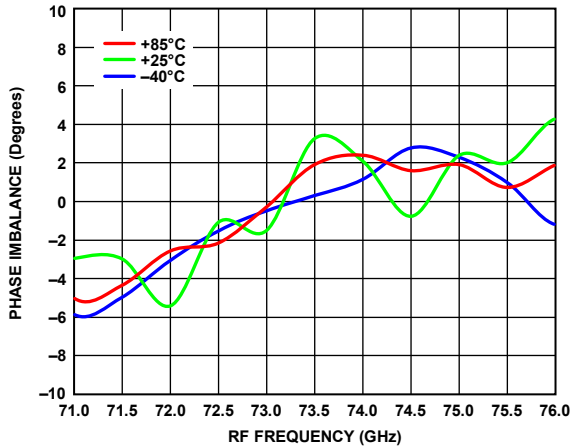


Figure 47. Phase Imbalance vs. RF Frequency over Temperature

20986-053

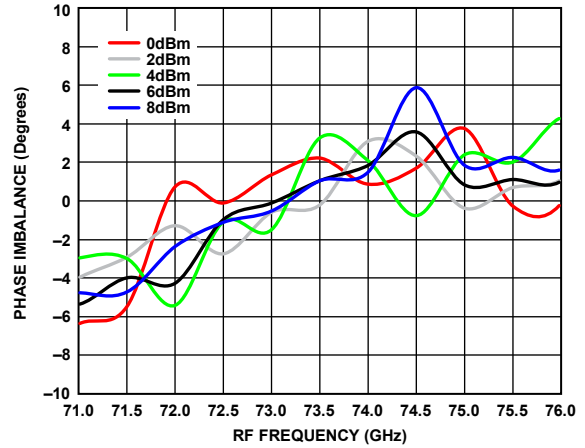


Figure 50. Phase Imbalance vs. RF Frequency over LO Power

20986-055

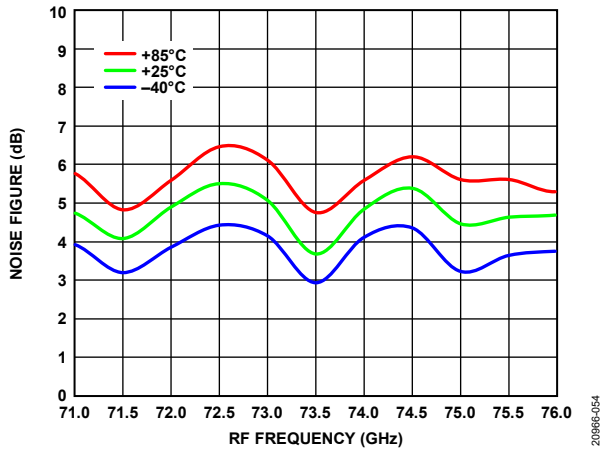


Figure 51. Noise Figure vs. RF Frequency over Temperature

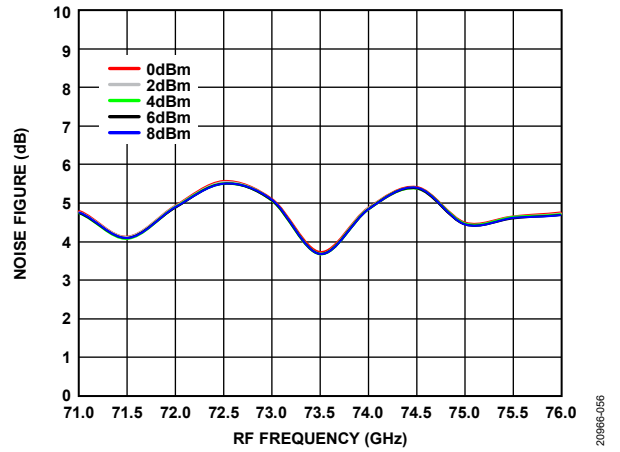


Figure 53. Noise Figure vs. RF Frequency over LO Power

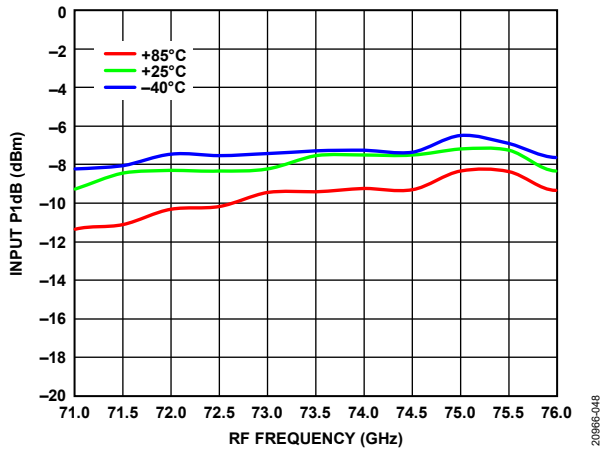


Figure 52. Input P1dB vs. RF Frequency over Temperature

20986-C54

20986-C56

20986-448

T<sub>A</sub> = 25°C, IF = 2 GHz, RFIN = -20 dBm combined, LO power = +4 dBm, and lower sideband selected, unless otherwise noted.

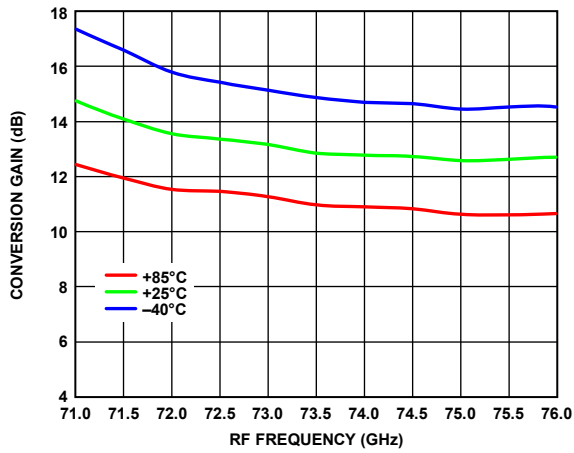


Figure 54. Conversion Gain vs. RF Frequency over Temperature

20986-057

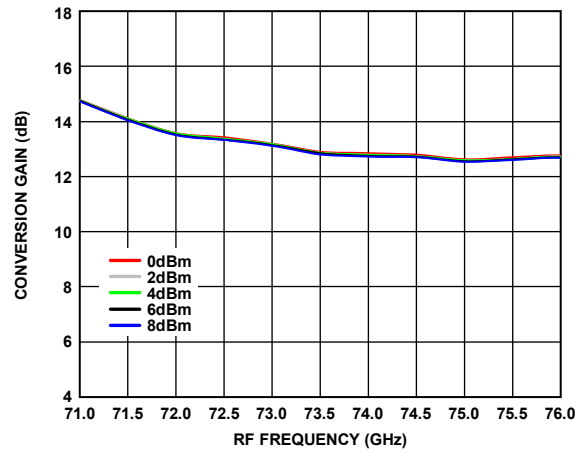


Figure 57. Conversion Gain vs. RF Frequency over LO Power

20986-060

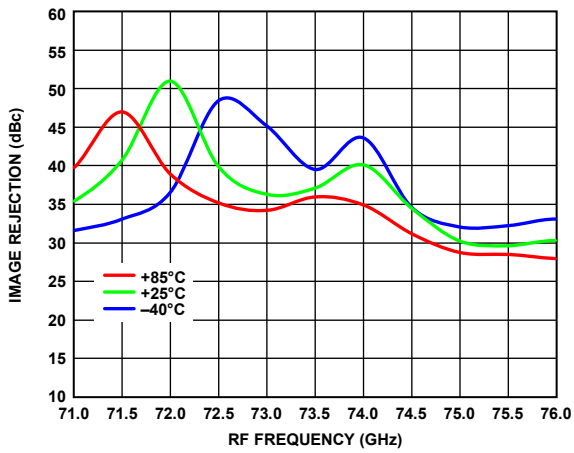


Figure 55. Image Rejection vs. RF Frequency over Temperature

20986-058

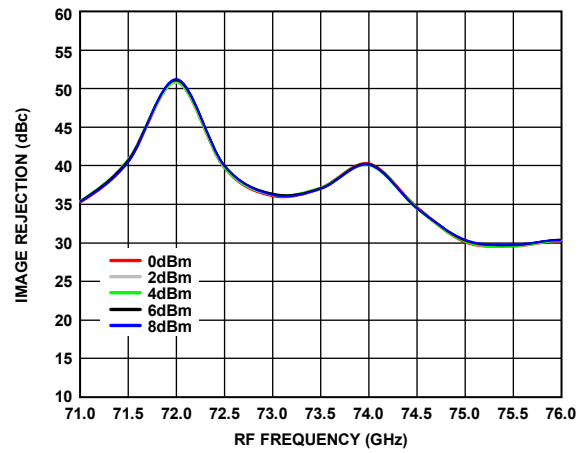


Figure 58. Image Rejection vs. RF Frequency over LO Power

20986-061

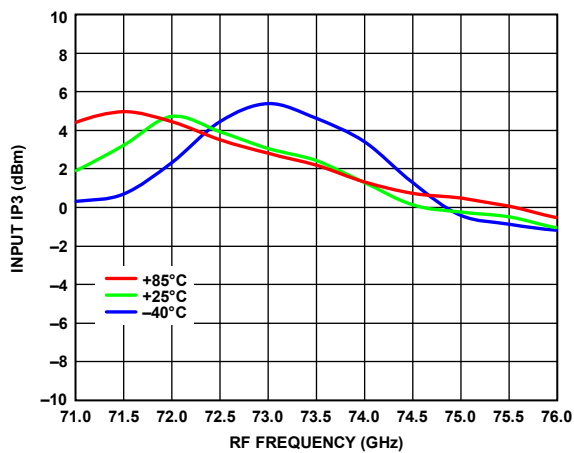


Figure 56. Input IP3 vs. RF Frequency over Temperature

20986-059

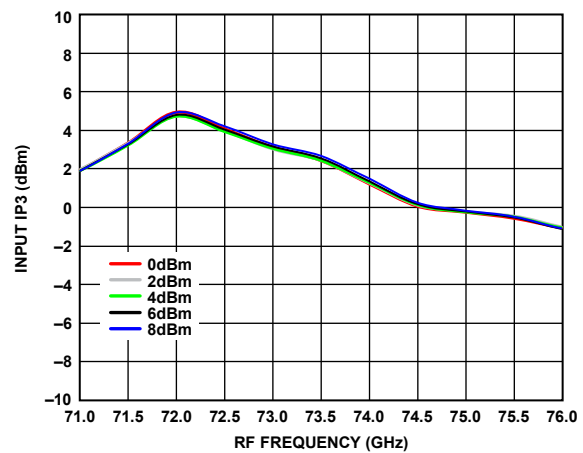


Figure 59. Input IP3 vs. RF Frequency over LO Power

20986-062



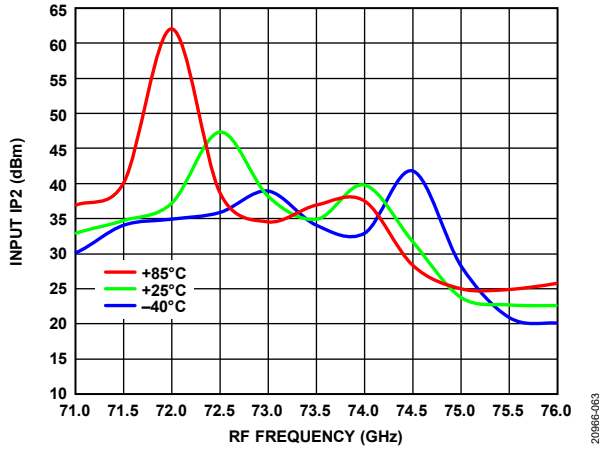


Figure 60. Input IP2 vs. RF Frequency over Temperature

20986-063

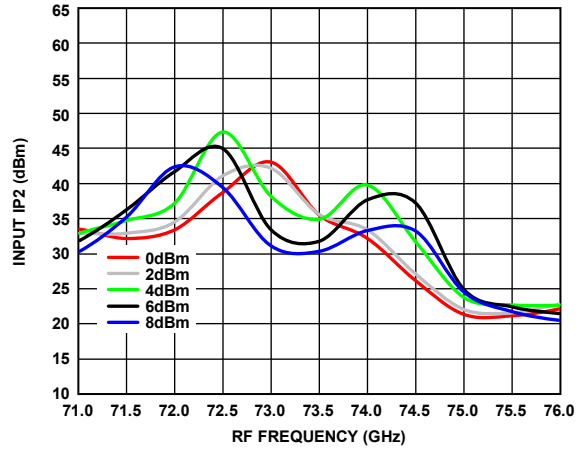


Figure 63. Input IP2 vs. RF Frequency over LO Power

20986-066

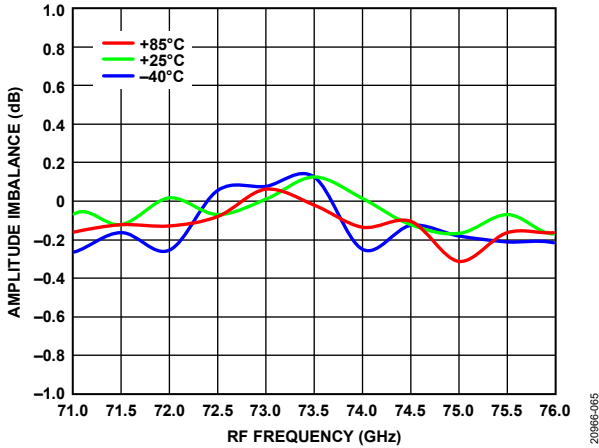


Figure 61. Amplitude Imbalance vs. RF Frequency over Temperature

20986-065

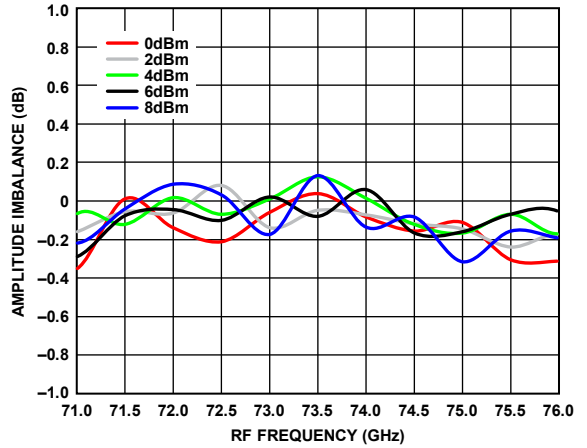


Figure 64. Amplitude Imbalance vs. RF Frequency over LO Power

20986-068

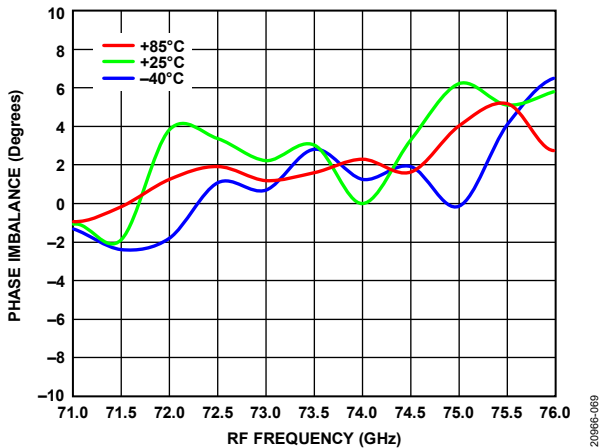


Figure 62. Phase Imbalance vs. RF Frequency over Temperature

20986-069

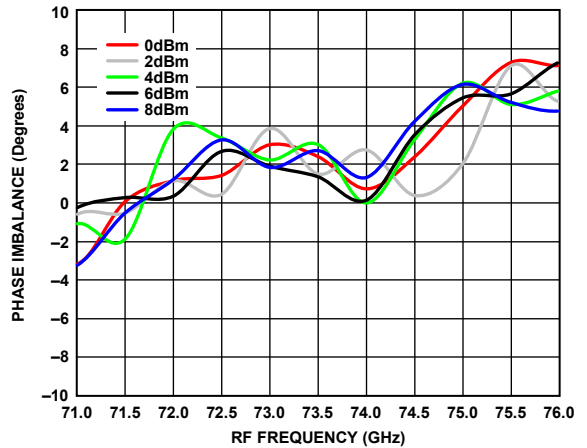


Figure 65. Phase Imbalance vs. RF Frequency over LO Power

20986-071

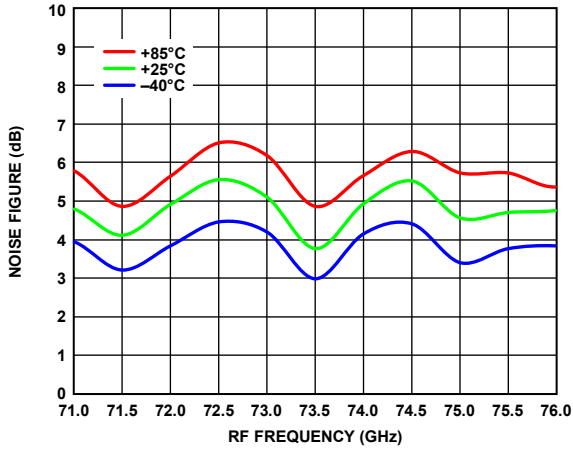


Figure 66. Noise Figure vs. RF Frequency over Temperature

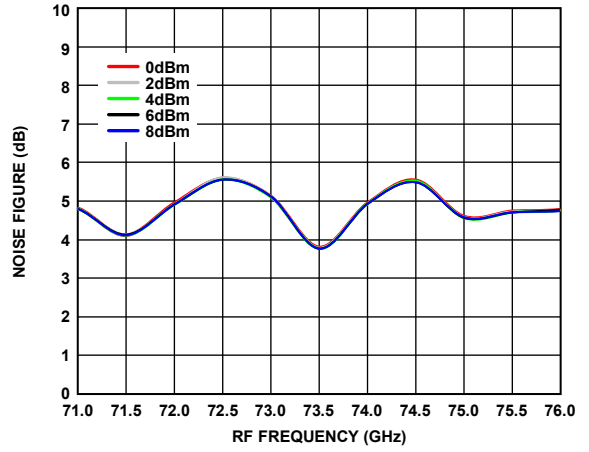


Figure 68. Noise Figure vs. RF Frequency over LO Power

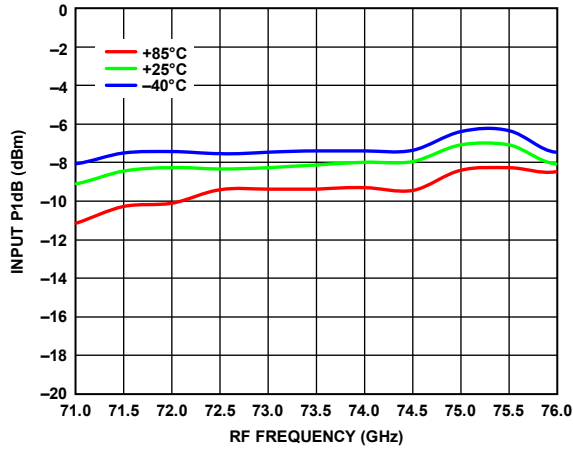


Figure 67. Input P1dB vs. RF Frequency over Temperature

20986-070

20986-072

20986-064

RETURN LOSS AND 6× LO LEAKAGE

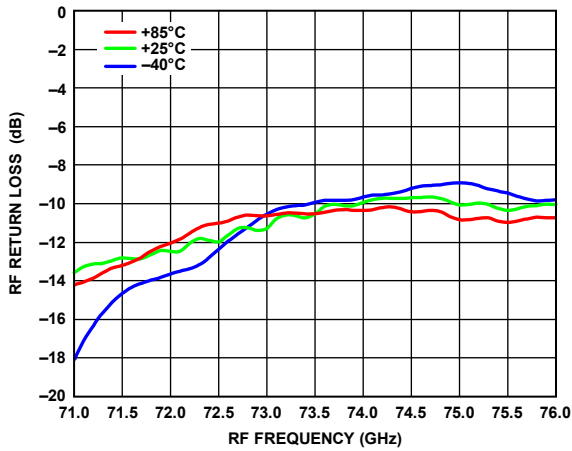


Figure 69. RF Return Loss vs. RF Frequency over Temperature  
LO Frequency = 11.8 GHz

20966-073

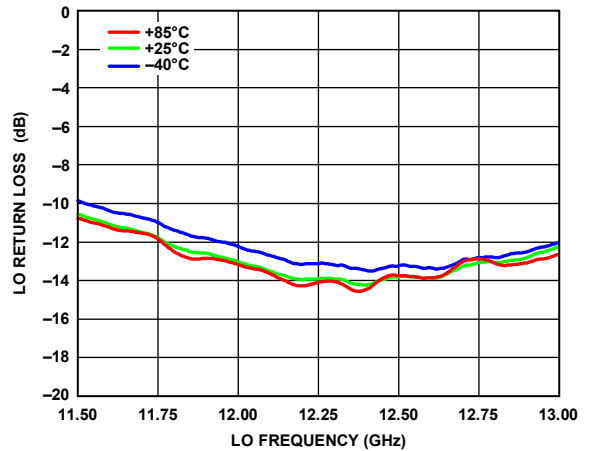


Figure 71. LO Return Loss vs. LO Frequency over Temperature

20966-075

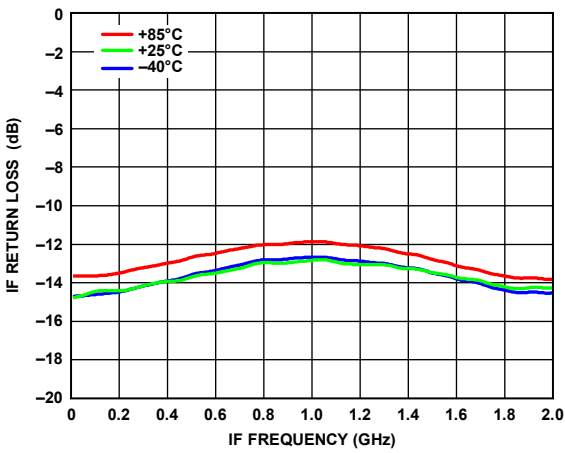


Figure 70. IF Return Loss vs. IF Frequency over Temperature  
LO Frequency = 11.8 GHz

20966-074

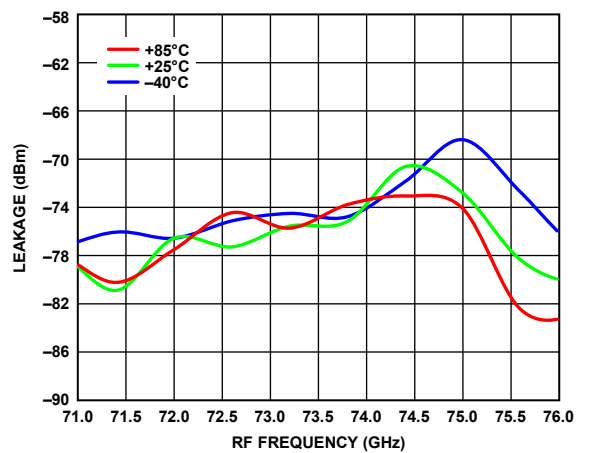


Figure 72. 6× LO Leakage at the RF Port over Temperature

20966-076

**SPURIOUS PERFORMANCE**

T<sub>A</sub> = 25°C, IF = 1 GHz, RFIN = -20 dBm, and LO input = +4 dBm, unless otherwise noted. Mixer spurious products are measured in dBc from the IF output power level single-ended for frequencies below 50 GHz, with all other IF ports terminated. Spur values are (M × RF) – (N × LO). N/A means not applicable.

**M × N Spurious Outputs, RF = 71 GHz, LO = 12 GHz**

		N × LO											
		0	1	2	3	4	5	6	7	8	12	18	
M × RF	0	N/A	-35	-55	-56	-73	<-80	<-80	<-80	<-80	<-80	<-80	<-80
	1	<-80	<-80	-75	-66	-85	-34	0	-34	-67	<-80	<-80	<-80
	2	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80	-74	-31	<-80	<-80
	3	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80	-42
	4	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80
	5	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80

**M × N Spurious Outputs, RF = 73.5 GHz, LO = 12.417 GHz**

		N × LO											
		0	1	2	3	4	5	6	7	8	12	18	
M × RF	0	N/A	-29	-84	-76	-69	<-80	<-80	<-80	<-80	<-80	<-80	<-80
	1	<-80	<-80	-73	-78	-82	-35	0	-37	-85	<-80	<-80	<-80
	2	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80	-73	-34	<-80	<-80
	3	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80	-96
	4	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80
	5	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80

**M × N Spurious Outputs, RF = 76 GHz, LO = 12.833 GHz**

		N × LO											
		0	1	2	3	4	5	6	7	8	12	18	
M × RF	0	N/A	-34	-84	-74	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80
	1	<-80	<-80	<-80	-74	-85	-91	0	-90	-83	<-80	<-80	<-80
	2	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80	-65	-33	<-80	<-80
	3	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80	-97
	4	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80
	5	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80	<-80

## THEORY OF OPERATION

The ADMV7410 is a fully integrated SiP, I/Q low noise downconverter that consists of two functional blocks.

The RFIN port of the ADMV7410 is connected to the gallium arsenide (GaAs), low noise amplifier that consists of four stages of low noise amplification that feed into the second block.

The second block is a GaAs, I/Q downconverter with an integrated LO buffer and 6× multiplier. The 6× multiplier allows the use of a lower frequency range LO input signal, typically between 11.5 GHz and 13 GHz. The 6× multiplier is

implemented using a cascade of 3× and 2× multipliers. The LO buffer amplifiers are included on chip to allow a typical LO drive level of 4 dBm for typical performance. The LO path feeds a quadrature splitter followed by on-chip baluns that drive the I and Q mixer cores. The mixer cores comprise singly balanced passive mixers. The RF input of the I and Q mixers are then driven through an on-chip Wilkinson power splitter, which is then fed by the first block of the ADMV7410.

# APPLICATIONS INFORMATION

## POWER-UP BIAS SEQUENCE

The ADMV7410 functional blocks use active multiple amplifier and multiplier stages that all use depletion mode pseudomorphic high electron mobility transistors (pHEMTs). To ensure transistor damage does not occur, use the following power-up bias sequence and do not apply RF power to the device on the LO or IF ports unless otherwise noted:

1. Apply a -2 V bias to VG\_MULT, VG\_AMP, VG12\_LNA, and VG34\_LNA.
2. Apply a -1 V bias to VG\_MIXER.
3. Apply a 2 V bias to VD12\_LNA.
4. Apply a 1.5 V bias to VD\_MULT.
5. Apply a 4 V bias to VD\_AMP and VD34\_LNA.
6. Adjust VG\_AMP between -2 V and 0 V to achieve a total  $I_{VD\_AMP}$  current of 175 mA.
7. Adjust VG12\_LNA between -2 V and 0 V to achieve a total  $I_{VD12\_LNA}$  current of 22 mA.
8. Adjust VG34\_LNA between -2 V and 0 V to achieve a total  $I_{VD34\_LNA}$  current of 44 mA.
9. Apply a LO input signal on the LO port and adjust VG\_MULT between -2 V and 0 V to achieve a total  $I_{VD\_MULT}$  current of 80 mA.

## POWER-DOWN SEQUENCE

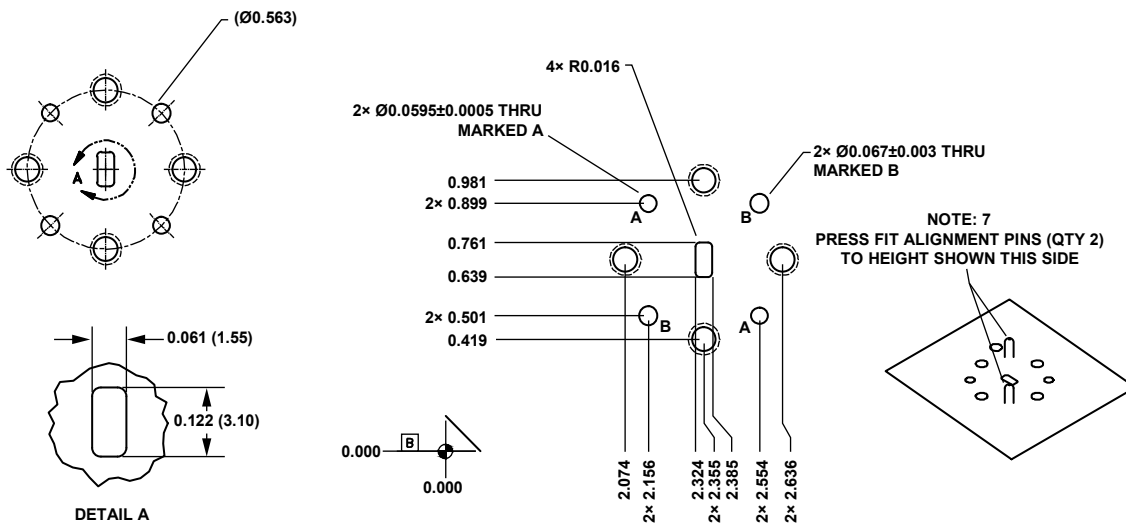
To power down the ADMV7410, take the following steps:

1. Apply a 0 V bias to VD\_MULT, VD\_AMP, VD12\_LNA, and VD34\_LNA.
2. Apply a 0 V bias to VG\_MIXER.
3. Apply a 0 V bias to VG\_MULT, VG\_AMP, VG12\_LNA, and VG34\_LNA.

## LAYOUT

Solder the exposed pad on the underside of the ADMV7410 to a low thermal and electrical impedance ground plane. This pad is typically soldered to an exposed opening in the solder mask. Connect these ground vias to all other ground layers to maximize heat dissipation from the device package.

Figure 73 illustrates the recommended mechanical layout on the interface plate used to interface to the WR-12 waveguide opening of the ADMV7410. The recommended PCB land pattern footprint is shown in Figure 74.



**NOTES:**

1. REMOVE BURRS AND BREAK SHARP EDGES.
2. ALL INTERNAL RADII ARE .090 UNLESS OTHERWISE NOTED.
3. SURFACE FINISH 32 RMS UNLESS OTHERWISE SPECIFIED.
4. DIMENSIONS APPLY AFTER PLATING.
5. MATERIAL: ALUMINUM 6061-T6 PER QQ-A-250/11.
6. FINISH: NONE.
7. INSTALL DOWEL PINS.
8. USE ELECTRONIC DATA FOR ALL GEOMETRY THAT IS NOT DIMENSIONED.

Figure 73. Recommended Standard WR-12 Footprint

20866-012

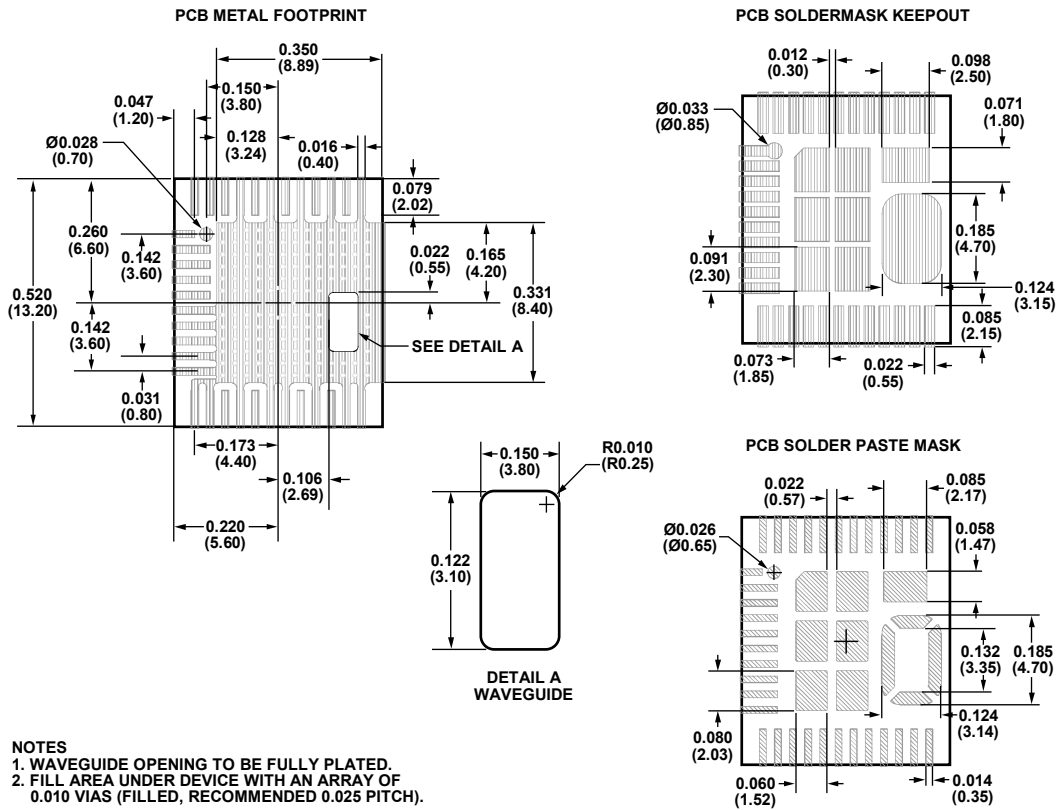


Figure 74. PCB Land Pattern Footprint

# TYPICAL APPLICATION CIRCUIT

Figure 75 shows the typical application circuit.

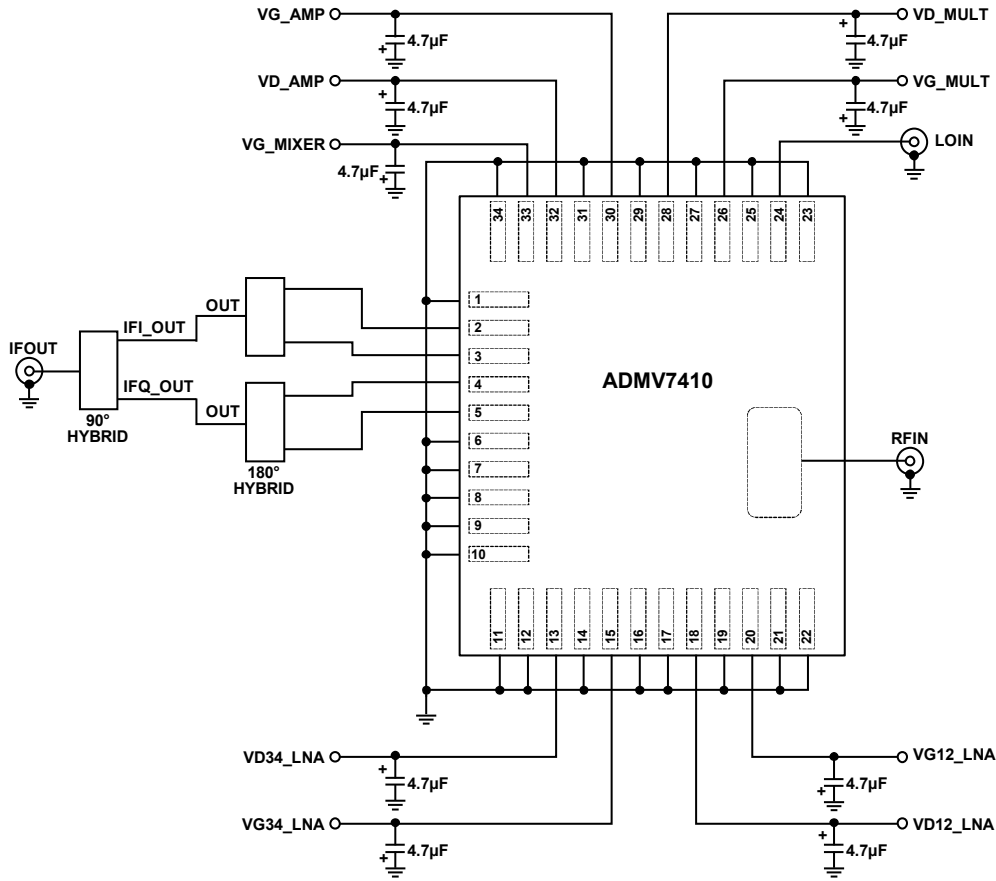


Figure 75. Typical Application Circuit

201966-078



# OUTLINE DIMENSIONS

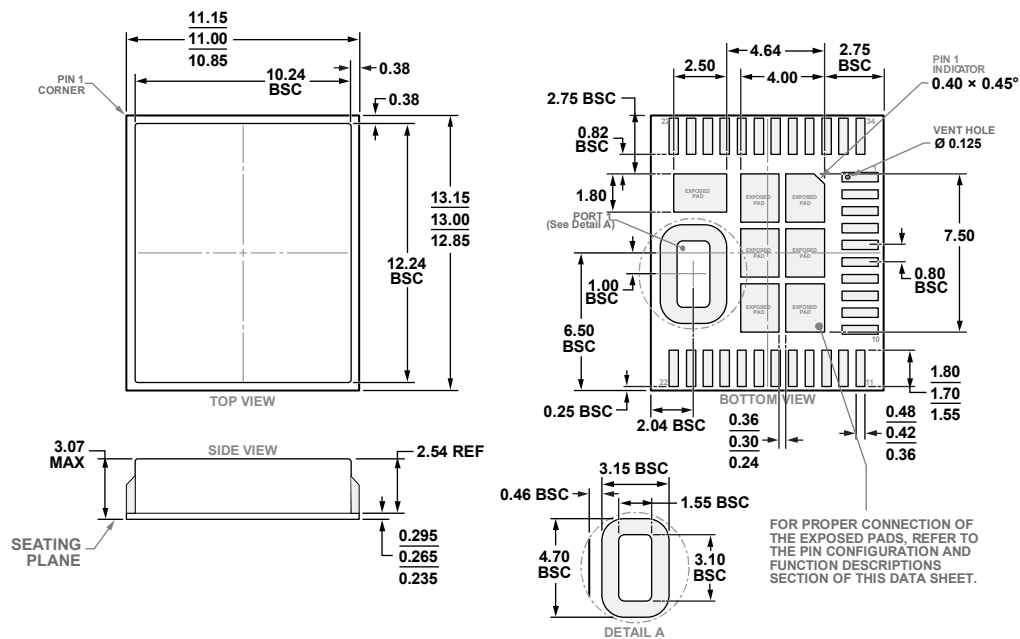


Figure 76. 34-Terminal Chip Array Small Outline No Lead Cavity [LGA\_CAV]  
 11.00 mm × 13.00 mm Body and 3.07 mm Maximum Package Height  
 (CE-34-2)  
 Dimensions shown in millimeters

## ORDERING GUIDE

Model <sup>1</sup>	Temperature Range	Package Description	Package Option
ADMV7410BCEZ	-40°C to +85°C	34-Terminal Chip Array Small Outline No Lead Cavity [LGA_CAV]	CE-34-2
ADMV7410-EVALZ		Evaluation Board	

<sup>1</sup> Z = RoHS Compliant Part.

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Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

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[ADMV7410-EVALZ](#)